TOSHIBA Transistor Silicon NPN Epitaxial Planar Type

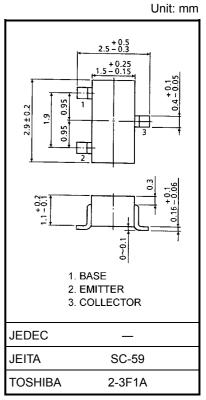
2SC5094

VHF~UHF Band Low Noise Amplifier Applications

- Low noise figure, high gain.
- NF = 1.8dB, $|S_{21e}|^2 = 7.5$ dB (f = 2 GHz)

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit	
Collector-base voltage	V _{CBO}	20	V	
Collector-emitter voltage	V _{CEO}	10	V	
Emitter-base voltage	V _{EBO}	1.5	V	
Base current	Ι _Β	7	mA	
Collector current	۱ _C	15	mA	
Collector power dissipation	P _C	150	mW	
Junction temperature	Тj	125	°C	
Storage temperature range	T _{stg}	-55~125	°C	



Microwave Characteristics (Ta = 25°C)

Weight: 0.012 g (typ.)

Characteristics	Symbol	Symbol Test Condition		Тур.	Max	Unit		
Transition frequency	f _T	$V_{CE} = 6 V, I_C = 7 mA$	7	10	_	GHz		
Insertion gain	S _{21e} ² (1)	$ ^{2}$ (1) $V_{CE} = 6 V, I_{C} = 7 mA, f = 1 GHz$ —				dB		
	S _{21e} ² (2)	$V_{CE} = 6 \text{ V}, I_C = 7 \text{ mA}, f = 2 \text{ GHz}$	4.5	7.5	_	uD		
Noise figure	NF (1)	(1) $V_{CE} = 6 V, I_C = 3 mA, f = 1 GHz$ —		1.4		dB		
	NF (2)	$V_{CE} = 6 \text{ V}, \text{ I}_{C} = 3 \text{ mA}, \text{ f} = 2 \text{ GHz}$	_	1.8	3.0	uВ		

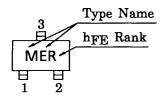
Electrical Characteristics (Ta = 25°C)

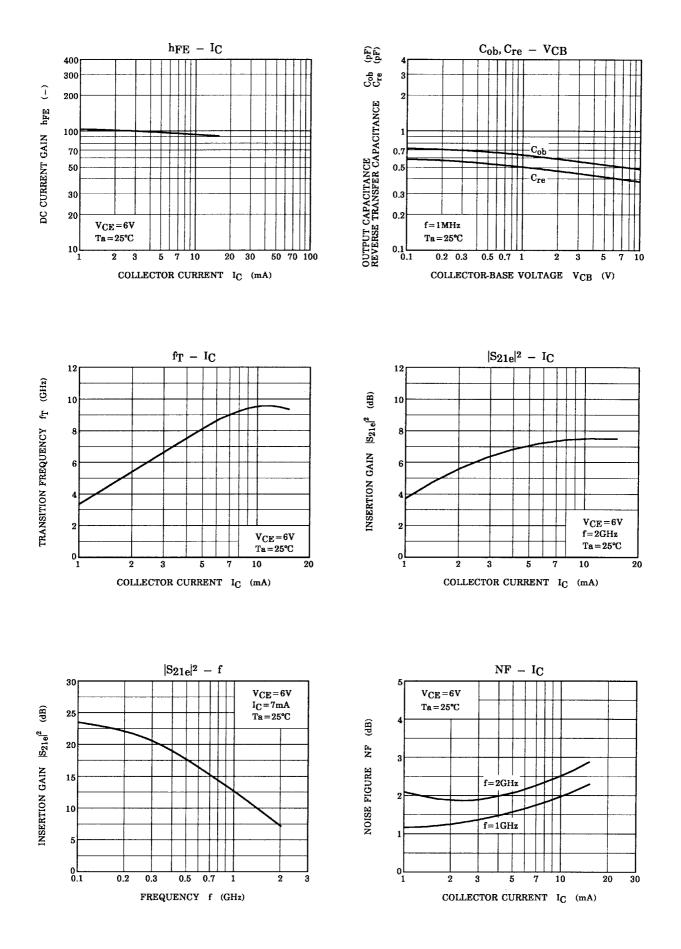
Characteristics Symbo		Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = 10 \text{ V}, \text{ I}_{E} = 0$		_	1	μA
Emitter cut-off current	I _{EBO}	$V_{EB} = 1 \text{ V}, I_{C} = 0$	_	_	1	μA
DC current gain	h _{FE} (Note 1)	$V_{CE} = 6 V, I_C = 7 mA$	50	_	160	
Output capacitance	C _{ob}	V _{CB} = 10 V, I _F = 0, f = 1 MHz (Note 2)	_	0.5	_	pF
Reverse transfer capacitance	C _{re}	$V_{CB} = 10$ V, $I_{E} = 0$, $I = 1$ MHZ (NOLE 2)	_	0.4	0.85	pF

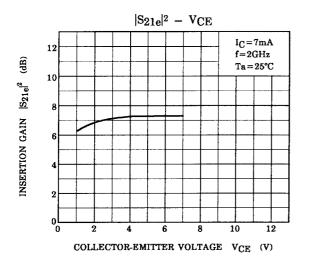
Note 1: hFE classification R: 50~100, O: 80~160

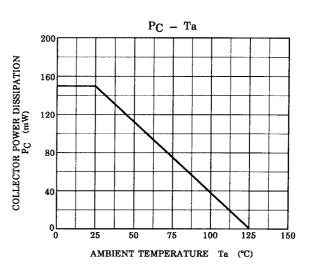
Note 2: Cre is measured by 3 terminal method with capacitance bridge.

Marking









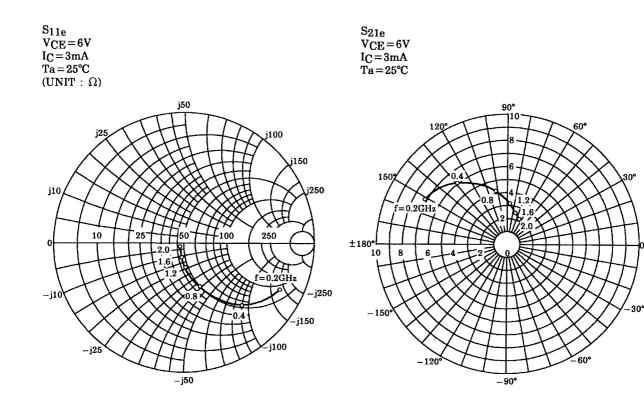
S-Parameter $Z_O = 50 \Omega$, Ta = 25°C

$V_{CE} = 6 V$, $I_C = 3 mA$

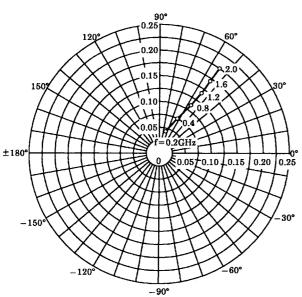
Frequency	S11		S21		S12		S22	
(MHz)	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.
200	0.817	-25.8	7.113	150.2	0.044	71.4	0.898	-18.6
400	0.647	-46.3	6.028	129.5	0.073	61.8	0.746	-28.7
600	0.477	-61.4	5.061	113.9	0.092	57.2	0.636	-33.4
800	0.356	-71.3	4.197	102.8	0.108	55.7	0.565	-35.4
1000	0.265	-78.9	3.583	93.9	0.123	55.3	0.518	-36.8
1200	0.194	-85.6	3.135	86.7	0.137	55.7	0.486	-37.5
1400	0.136	-90.5	2.778	80.2	0.153	55.8	0.467	-38.8
1600	0.093	-97.7	2.490	74.4	0.169	55.3	0.449	-40.4
1800	0.058	-109.0	2.260	69.6	0.183	54.8	0.433	-42.6
2000	0.028	-134.7	2.089	65.2	0.199	55.2	0.418	-43.9

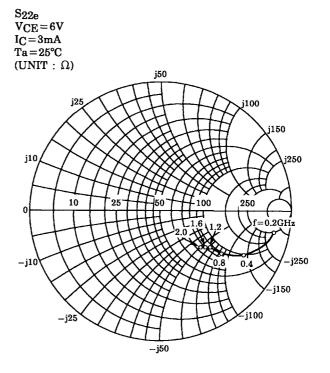
$V_{CE} = 6 V$, $I_C = 7 mA$

Frequency	S	11	S2	21	Sí	12	S2	22
(MHz)	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.
200	0.630	-39.7	12.332	138.1	0.037	68.5	0.783	-25.6
400	0.392	-64.1	8.847	114.7	0.059	64.3	0.586	-31.8
600	0.248	-78.3	6.514	101.4	0.077	64.1	0.495	-32.0
800	0.161	-87.5	5.094	92.6	0.096	64.7	0.449	-31.2
1000	0.105	-95.3	4.213	85.9	0.114	64.9	0.423	-30.5
1200	0.060	-106.3	3.589	80.3	0.133	65.0	0.412	-30.8
1400	0.028	-121.7	3.139	74.9	0.154	64.0	0.406	-32.1
1600	0.021	-158.4	2.786	70.1	0.173	62.5	0.398	-34.0
1800	0.035	171.6	2.498	66.0	0.190	61.2	0.387	-36.7
2000	0.054	144.0	2.300	62.3	0.210	60.7	0.377	-38.4



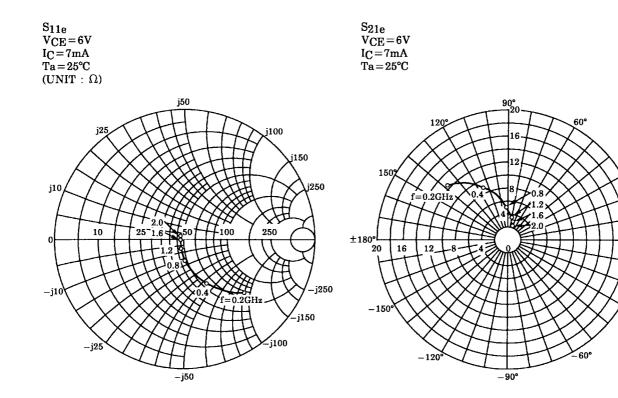






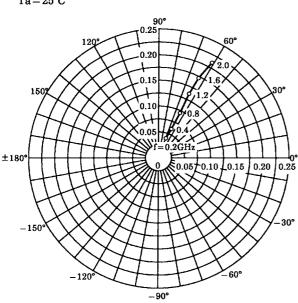
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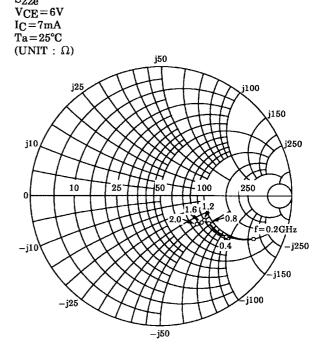
-30°



 S_{22e}







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